

Notice of References Cited	Application/Control No. 10/823,443	Applicant(s)/Patent Under Reexamination WIEN ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,854,303	12-1998	Powell et al.	523/106
*	B	US-6,465,065	10-2002	Teumac et al.	428/35.7
*	C	US-6,933,046	08-2005	Cook, Ronald Lee	428/402
*	D	US-4,585,559	04-1986	DeVoe et al.	210/679
*	E	US-6,830,694	12-2004	Schiestel et al.	210/660
*	F	US-5,492,742	02-1996	Zenner et al.	428/35.2
*	G	US-6,616,997	09-2003	Lauer et al.	428/36.5
*	H	US-7,029,768	04-2006	Ohmori et al.	428/702
*	I	US-6,548,264	04-2003	Tan et al.	435/7.21
*	J	US-6,933,055	08-2005	Share et al.	428/474.4
*	K	US-6,106,866	08-2000	Ranney, David F.	424/499
*	L	US-4,612,122	09-1986	Ambrus et al.	210/638
*	M	US-6,667,082	12-2003	Bamore et al.	428/34.8

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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